Data Conversion and the Sample-Message Bounds

Latency and Time Concerns

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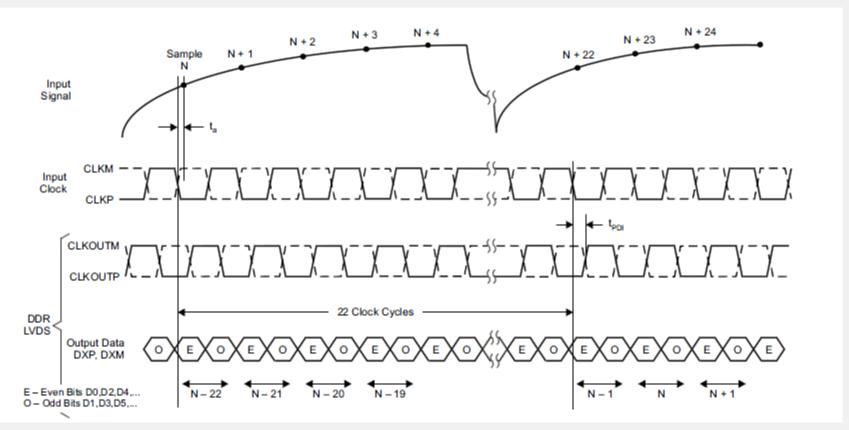
Collection and Emission

- "Collection": Analog/Digital Converters (ADCs) accept an analog input signal and produce a discrete time series – a "collection" process
- "Emission": Digital/Analog Converters (DACs) accept a discrete time series and produce an analog output – an "emission" process
- Synonymous with
 - Receive and Transmit (SIGINT/SDR/EW)
 - Acquire and Display (Image Exploitation)
 - Record and Playback (Data/Instrumentation Recording)
 - Ingress and Egress (Networking)
 - In and Out (from the digital system actor's view)

Latency

- Most converters have a fixed delay between their analog and digital domains
 - TI ADS62P49, 22 cycles@250MHz = 88 nS latency
 - Same device, Aperture Delay = 1.7 nS
 - Same device, Aperture Uncertainty = 1000 pS
 - Same device, Aperture Jitter= 145 fS (RMS)
- Strong motivation to
 - Mitigate the substantial (fixed, known) latency
 - Not to degrade the (superb, small) variation

Converter Latency



Ref: TI ADS62P49 Data Sheet

Time

- Actual Time Time in the analog domain with regard to an unstoppable timing reference
 - In the preceding figure, when Sample-N is captured
- Signal Time Time in the digital domain that may advance in synchrony or not; faster or slower, and even stop
 - In the preceding figure, when Sample-N is output

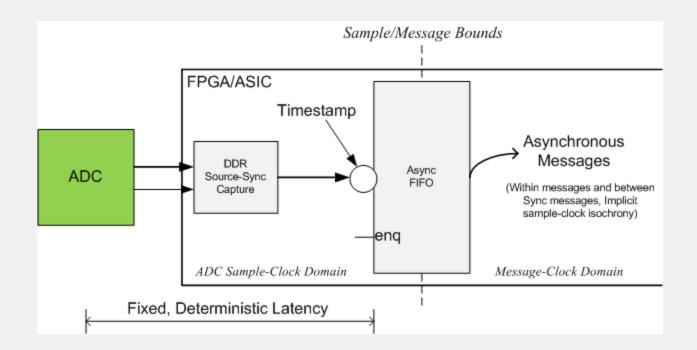
Ref: VITA-49 Appendix B.8

Deterministic Latency

- Discrete, digital samples marching from an ADC or to an DAC generally have a fixed, specified latency
 - Sample time is related to Actual time by the sample rate
- When latency is fixed, actual and signal time relationships can be calculated
 - When latency is uncertain, so too is the actual/signal time relationship

Sample-Message Bounds

- The point in the data collection/emission process where digitized samples are converted to/from messages is termed the "sample-message bounds"
 - Periodic (Isochronous) Samples ← Asynchronous Message Stream
 - Practical point of timestamp insertion



Device Interface IP

- ASIC/FPGA design decisions can influence the collection/emission time uncertainty
- Implementations which resolve actual- and signal- time in the sample-clock domain are immune to FIFO fall-through uncertainties
 - Fall-through uncertainties can be 100s of sample clock periods
- Implementing time-rendezvous in the sampleclock domain can be challenging

OpenCPI ADCWorker – 3 sample delay

